

Notice of References Cited

Application/Control No.

09/756,694

Applicant(s)/Patent Under
Reexamination
SHIM ET AL.

Examiner

Sudhanshu C. Pathak

Art Unit

2634

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,917,855	06-1999	Kim, Sung-jin	375/229
	B	US-5,455,813	10-1995	Hayashi, Hideki	369/59.21
	C	US-6,198,587	03-2001	Hayashi, Hideki	360/65
	D	US-6,552,988	04-2003	Nishiwaki et al.	369/59.22
	E	US-5,508,993	04-1996	Hayashi et al.	369/59.22
	F	US-6,275,967	08-2001	Kuki, Ryohei	714/809
	G	US-6,108,354	08-2000	Scull et al.	370/523
	H	US-6,600,779	07-2003	Sawada et al.	375/233
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	JP-8249829; Uchida Narichika; English Machine Translation.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

76